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#### Understanding **Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

#### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

##### **Details**

Product Status	Active
Number of LABs/CLBs	-
Number of Logic Elements/Cells	-
Total RAM Bits	-
Number of I/O	57
Number of Gates	3000
Voltage - Supply	3V ~ 3.6V, 4.5V ~ 5.5V
Mounting Type	Surface Mount
Operating Temperature	-55°C ~ 125°C (TC)
Package / Case	80-TQFP
Supplier Device Package	80-VQFP (14x14)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/microchip-technology/a40mx02-1vqg80m">https://www.e-xfl.com/product-detail/microchip-technology/a40mx02-1vqg80m</a>

## 3 40MX and 42MX FPGAs

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### 3.1 General Description

Microsemi's 40MX and 42MX families offer a cost-effective design solution at 5V. The MX devices are single-chip solutions and provide high performance while shortening the system design and development cycle. MX devices can integrate and consolidate logic implemented in multiple PALs, CPLDs, and FPGAs. Example applications include high-speed controllers and address decoding, peripheral bus interfaces, DSP, and co-processor functions.

The MX device architecture is based on Microsemi's patented antifuse technology implemented in a 0.45 $\mu$ m triple-metal CMOS process. With capacities ranging from 3,000 to 54,000 system gates, the MX devices provide performance up to 250 MHz, are live on power-up and have one-fifth the standby power consumption of comparable FPGAs. MX FPGAs provide up to 202 user I/Os and are available in a wide variety of packages and speed grades.

A42MX24 and A42MX36 devices also feature multiPlex I/Os, which support mixed-voltage systems, enable programmable PCI, deliver high-performance operation at both 5.0V and 3.3V, and provide a low-power mode. The devices are fully compliant with the PCI local bus specification (version 2.1). They deliver 200 MHz on-chip operation and 6.1 ns clock-to-output performance.

The 42MX24 and 42MX36 devices include system-level features such as IEEE Standard 1149.1 (JTAG) Boundary Scan Testing and fast wide-decode modules. In addition, the A42MX36 device offers dual-port SRAM for implementing fast FIFOs, LIFOs, and temporary data storage. The storage elements can efficiently address applications requiring wide data path manipulation and can perform transformation functions such as those required for telecommunications, networking, and DSP.

All MX devices are fully tested over automotive and military temperature ranges. In addition, the largest member of the family, the A42MX36, is available in both CQ208 and CQ256 ceramic packages screened to MIL-STD-883 levels. For easy prototyping and conversion from plastic to ceramic, the CQ208 and PQ208 devices are pin-compatible.

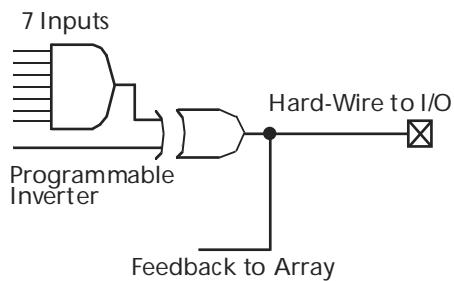
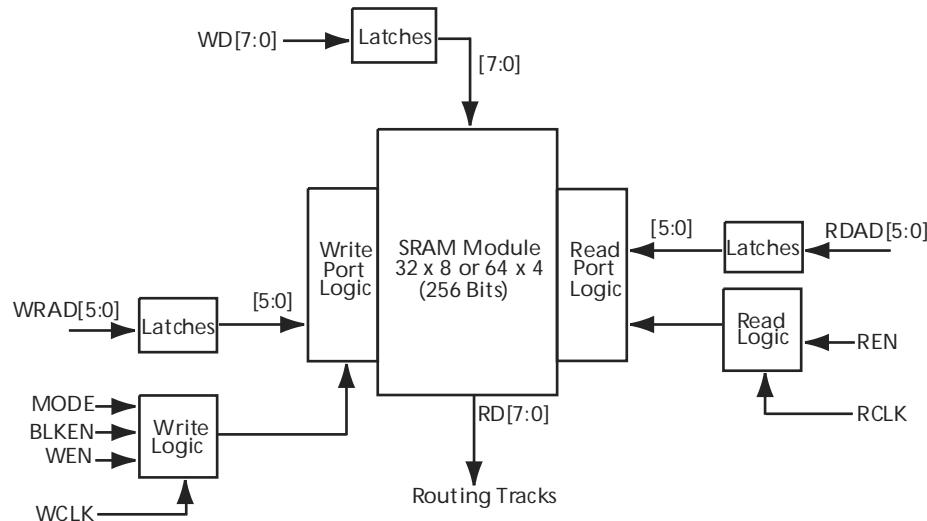
### 3.2 MX Architectural Overview

The MX devices are composed of fine-grained building blocks that enable fast, efficient logic designs. All devices within these families are composed of logic modules, I/O modules, routing resources and clock networks, which are the building blocks for fast logic designs. In addition, the A42MX36 device contains embedded dual-port SRAM modules, which are optimized for high-speed data path functions such as FIFOs, LIFOs and scratch pad memory. A42MX24 and A42MX36 also contain wide-decode modules.

#### 3.2.1 Logic Modules

The 40MX logic module is an eight-input, one-output logic circuit designed to implement a wide range of logic functions with efficient use of interconnect routing resources.(see the following figure).

The logic module can implement the four basic logic functions (NAND, AND, OR and NOR) in gates of two, three, or four inputs. The logic module can also implement a variety of D-latches, exclusivity functions, AND-ORs and OR-ANDs. No dedicated hard-wired latches or flip-flops are required in the array; latches and flip-flops can be constructed from logic modules whenever required in the application.

**Figure 5 • A42MX24 and A42MX36 D-Module Implementation****Figure 6 • A42MX36 Dual-Port SRAM Block**

### 3.2.3 Routing Structure

The MX architecture uses vertical and horizontal routing tracks to interconnect the various logic and I/O modules. These routing tracks are metal interconnects that may be continuous or split into segments. Varying segment lengths allow the interconnect of over 90% of design tracks to occur with only two antifuse connections. Segments can be joined together at the ends using antifuses to increase their lengths up to the full length of the track. All interconnects can be accomplished with a maximum of four antifuses.

#### 3.2.3.1 Horizontal Routing

Horizontal routing tracks span the whole row length or are divided into multiple segments and are located in between the rows of modules. Any segment that spans more than one-third of the row length is considered a long horizontal segment. A typical channel is shown in Figure 7, page 10. Within horizontal routing, dedicated routing tracks are used for global clock networks and for power and ground tie-off tracks. Non-dedicated tracks are used for signal nets.

#### 3.2.3.2 Vertical Routing

Another set of routing tracks run vertically through the module. There are three types of vertical tracks: input, output, and long. Long tracks span the column length of the module, and can be divided into multiple segments. Each segment in an input track is dedicated to the input of a particular module; each segment in an output track is dedicated to the output of a particular module. Long segments are uncommitted and can be assigned during routing.

Each output segment spans four channels (two above and two below), except near the top and bottom of the array, where edge effects occur. Long vertical tracks contain either one or two segments. An example of vertical routing tracks and segments is shown in Figure 7, page 10.

$f_{q2}$  = Average second routed array clock rate in MHz)

**Table 7 • Fixed Capacitance Values for MX FPGAs (pF)**

Device Type	r1 routed_Clk1	r2 routed_Clk2
A40MX02	41.4	N/A
A40MX04	68.6	N/A
A42MX09	118	118
A42MX16	165	165
A42MX24	185	185
A42MX36	220	220

### 3.4.6 Test Circuitry and Silicon Explorer II Probe

MX devices contain probing circuitry that provides built-in access to every node in a design, via the use of Silicon Explorer II. Silicon Explorer II is an integrated hardware and software solution that, in conjunction with the Designer software, allow users to examine any of the internal nets of the device while it is operating in a prototyping or a production system. The user can probe into an MX device without changing the placement and routing of the design and without using any additional resources. Silicon Explorer II's noninvasive method does not alter timing or loading effects, thus shortening the debug cycle and providing a true representation of the device under actual functional situations.

Silicon Explorer II samples data at 100 MHz (asynchronous) or 66 MHz (synchronous). Silicon Explorer II attaches to a PC's standard COM port, turning the PC into a fully functional 18-channel logic analyzer. Silicon Explorer II allows designers to complete the design verification process at their desks and reduces verification time from several hours per cycle to a few seconds.

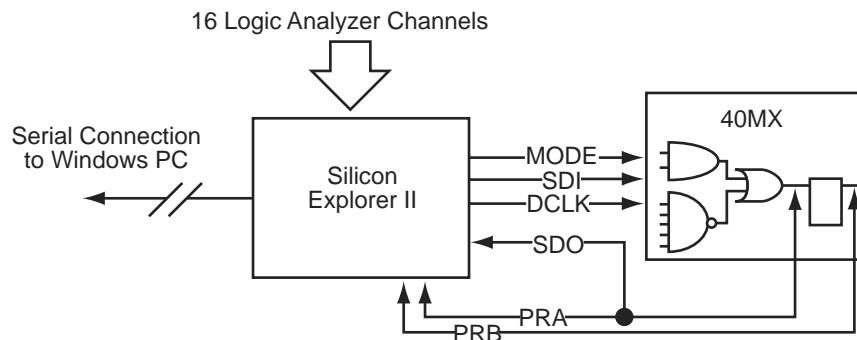
Silicon Explorer II is used to control the MODE, DCLK, SDI and SDO pins in MX devices to select the desired nets for debugging. The user simply assigns the selected internal nets in the Silicon Explorer II software to the PRA/PRB output pins for observation. Probing functionality is activated when the MODE pin is held HIGH.

Figure 12, page 16 illustrates the interconnection between Silicon Explorer II and 40MX devices, while Figure 13, page 17 illustrates the interconnection between Silicon Explorer II and 42MX devices.

To allow for probing capabilities, the security fuses must not be programmed. (See User Security, page 12 for the security fuses of 40MX and 42MX devices). Table 8, page 17 summarizes the possible device configurations for probing.

PRA and PRB pins are dual-purpose pins. When the "Reserve Probe Pin" is checked in the Designer software, PRA and PRB pins are reserved as dedicated outputs for probing. If PRA and PRB pins are required as user I/Os to achieve successful layout and "Reserve Probe Pin" is checked, the layout tool will override the option and place user I/Os on PRA and PRB pins.

**Figure 12 • Silicon Explorer II Setup with 40MX**



**Table 35 • A40MX02 Timing Characteristics (Nominal 3.3 V Operation) (continued)**  
**(Worst-Case Commercial Conditions, VCC = 3.0 V, TJ = 70°C)**

<b>Parameter / Description</b>	<b>-3 Speed</b>		<b>-2 Speed</b>		<b>-1 Speed</b>		<b>Std Speed</b>		<b>-F Speed</b>		<b>Units</b>
	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	
t <sub>RD1</sub>	FO = 1 Routing Delay		2.0		2.2		2.5		3.0		4.2 ns
t <sub>RD2</sub>	FO = 2 Routing Delay		2.7		3.1		3.5		4.1		5.7 ns
t <sub>RD3</sub>	FO = 3 Routing Delay		3.4		3.9		4.4		5.2		7.3 ns
t <sub>RD4</sub>	FO = 4 Routing Delay		4.2		4.8		5.4		6.3		8.9 ns
t <sub>RD8</sub>	FO = 8 Routing Delay		7.1		8.2		9.2		10.9		15.2 ns
<b>Logic Module Sequential Timing<sup>2</sup></b>											
t <sub>SUD</sub>	Flip-Flop (Latch) Data Input Set-Up		4.3		4.9		5.6		6.6		9.2 ns
t <sub>HD</sub> <sup>3</sup>	Flip-Flop (Latch) Data Input Hold		0.0		0.0		0.0		0.0		ns
t <sub>SUENA</sub>	Flip-Flop (Latch) Enable Set-Up	4.3		4.9		5.6		6.6		9.2	ns
t <sub>HENA</sub>	Flip-Flop (Latch) Enable Hold	0.0		0.0		0.0		0.0		0.0	ns
t <sub>WCLKA</sub>	Flip-Flop (Latch) Clock Active Pulse Width		4.6		5.3		6.0		7.0		9.8 ns
t <sub>WASYN</sub>	Flip-Flop (Latch) Asynchronous Pulse Width		4.6		5.3		6.0		7.0		9.8 ns
t <sub>A</sub>	Flip-Flop Clock Input Period	6.8		7.8		8.9		10.4		14.6	ns
f <sub>MAX</sub>	Flip-Flop (Latch) Clock Frequency (FO = 128)		109		101		92		80		48 MHz
<b>Input Module Propagation Delays</b>											
t <sub>INYH</sub>	Pad-to-Y HIGH		1.0		1.1		1.3		1.5		2.1 ns
t <sub>INYL</sub>	Pad-to-Y LOW		0.9		1.0		1.1		1.3		1.9 ns
<b>Input Module Predicted Routing Delays<sup>1</sup></b>											
t <sub>IRD1</sub>	FO = 1 Routing Delay		2.9		3.4		3.8		4.5		6.3 ns
t <sub>IRD2</sub>	FO = 2 Routing Delay		3.6		4.2		4.8		5.6		7.8 ns
t <sub>IRD3</sub>	FO = 3 Routing Delay		4.4		5.0		5.7		6.7		9.4 ns
t <sub>IRD4</sub>	FO = 4 Routing Delay		5.1		5.9		6.7		7.8		11.0 ns
t <sub>IRD8</sub>	FO = 8 Routing Delay		8.0		9.26		10.5		12.6		17.3 ns
<b>Global Clock Network</b>											
t <sub>CKH</sub>	Input LOW to HIGH FO = 16		6.4		7.4		8.3		9.8		13.7 ns
	FO = 128		6.4		7.4		8.3		9.8		13.7
t <sub>CKL</sub>	Input HIGH to LOW FO = 16		6.7		7.8		8.8		10.4		14.5 ns
	FO = 128		6.7		7.8		8.8		10.4		14.5
t <sub>PWH</sub>	Minimum Pulse Width HIGH	FO = 16	3.1		3.6		4.1		4.8		6.7 ns
	FO = 128		3.3		3.8		4.3		5.1		7.1
t <sub>PWL</sub>	Minimum Pulse Width LOW	FO = 16	3.1		3.6		4.1		4.8		6.7 ns
	FO = 128		3.3		3.8		4.3		5.1		7.1
t <sub>CKSW</sub>	Maximum Skew	FO = 16	0.6		0.6		0.7		0.8		1.2 ns
	FO = 128		0.8		0.9		1.0		1.2		1.6

**Table 39 • A42MX09 Timing Characteristics (Nominal 3.3 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 3.0 V, TJ = 70°C)**

<b>Parameter / Description</b>	<b>-3 Speed</b>		<b>-2 Speed</b>		<b>-1 Speed</b>		<b>Std Speed</b>		<b>-F Speed</b>		<b>Units</b>
	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	
<b>TTL Output Module Timing<sup>5</sup></b>											
t <sub>DLH</sub>	Data-to-Pad HIGH		3.4		3.8		4.3		5.1		7.1 ns
t <sub>DHL</sub>	Data-to-Pad LOW		4.0		4.5		5.1		6.1		8.3 ns
t <sub>ENZH</sub>	Enable Pad Z to HIGH		3.7		4.1		4.6		5.5		7.6 ns
t <sub>ENZL</sub>	Enable Pad Z to LOW		4.1		4.5		5.1		6.1		8.5 ns
t <sub>ENHZ</sub>	Enable Pad HIGH to Z		6.9		7.6		8.6		10.2		14.2 ns
t <sub>ENLZ</sub>	Enable Pad LOW to Z		7.5		8.3		9.4		11.1		15.5 ns
t <sub>GLH</sub>	G-to-Pad HIGH		5.8		6.5		7.3		8.6		12.0 ns
t <sub>GHL</sub>	G-to-Pad LOW		5.8		6.5		7.3		8.6		12.0 ns
t <sub>LSU</sub>	I/O Latch Set-Up	0.7		0.8		0.9		1.0		1.4	ns
t <sub>LH</sub>	I/O Latch Hold	0.0		0.0		0.0		0.0		0.0	ns
t <sub>LCO</sub>	I/O Latch Clock-to-Out (Pad-to-Pad), 64 Clock Loading		8.7		9.7		10.9		12.9		18.0 ns
t <sub>ACO</sub>	Array Clock-to-Out (Pad-to-Pad), 64 Clock Loading		12.2		13.5		15.4		18.1		25.3 ns
d <sub>TLH</sub>	Capacity Loading, LOW to HIGH	0.00		0.00		0.00		0.10		0.01	ns/pF
d <sub>THL</sub>	Capacity Loading, HIGH to LOW	0.09		0.10		0.10		0.10		0.10	ns/pF

**Table 43 • A42MX24 Timing Characteristics (Nominal 3.3 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 3.0 V, TJ = 70°C)**

Parameter / Description		-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed	
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.
<b>TTL Output Module Timing<sup>5</sup> (continued)</b>											
t <sub>LH</sub>	I/O Latch Output Hold	0.0	0.0	0.0	0.0	0.0	0.0	0.0	0.0	ns	
t <sub>LCO</sub>	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O		7.7	8.5	9.6		11.3		15.9	ns	
t <sub>ACO</sub>	Array Latch Clock-to-Out (Pad-to-Pad) 32 I/O		14.8	16.5	18.7		22.0		30.8	ns	
d <sub>TLH</sub>	Capacitive Loading, LOW to HIGH	0.05	0.05	0.06	0.07		0.10	ns/pF			
d <sub>THL</sub>	Capacitive Loading, HIGH to LOW	0.04	0.04	0.05	0.06		0.08	ns/pF			
<b>CMOS Output Module Timing<sup>5</sup></b>											
t <sub>DLH</sub>	Data-to-Pad HIGH	4.8	5.3	5.5	6.4		9.0	ns			
t <sub>DHL</sub>	Data-to-Pad LOW	3.5	3.9	4.1	4.9		6.8	ns			
t <sub>ENZH</sub>	Enable Pad Z to HIGH	3.6	4.0	4.5	5.3		7.4	ns			
t <sub>ENZL</sub>	Enable Pad Z to LOW	3.4	4.0	5.0	5.8		8.2	ns			
t <sub>ENHZ</sub>	Enable Pad HIGH to Z	7.2	8.0	9.0	10.7		14.9	ns			
t <sub>ENLZ</sub>	Enable Pad LOW to Z	6.7	7.5	8.5	9.9		13.9	ns			
t <sub>GLH</sub>	G-to-Pad HIGH	6.8	7.6	8.6	10.1		14.2	ns			
t <sub>GHL</sub>	G-to-Pad LOW	6.8	7.6	8.6	10.1		14.2	ns			
t <sub>LSU</sub>	I/O Latch Set-Up	0.7	0.7	0.8	1.0		1.4	ns			
t <sub>LH</sub>	I/O Latch Hold	0.0	0.0	0.0	0.0		0.0	ns			
t <sub>LCO</sub>	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O		7.7	8.5	9.6		11.3		15.9	ns	
t <sub>ACO</sub>	Array Latch Clock-to-Out (Pad-to-Pad) 32 I/O		14.8	16.5	18.7		22.0		30.8	ns	
d <sub>TLH</sub>	Capacitive Loading, LOW to HIGH	0.05	0.05	0.06	0.07		0.10	ns/pF			
d <sub>THL</sub>	Capacitive Loading, HIGH to LOW	0.04	0.04	0.05	0.06		0.08	ns/pF			
t <sub>HEXT</sub>	Input Latch External Hold	FO = 32 FO = 486	3.9 4.6	4.3 5.2	4.9 5.8		5.7 6.9	8.1 9.6	ns ns		
t <sub>P</sub>	Minimum Period (1/f <sub>MAX</sub> )	FO = 32 FO = 486	7.8 8.6	8.7 9.5	9.5 10.4		10.8 11.9	18.2 19.9	ns ns		

- For dual-module macros, use t<sub>PD1</sub> + t<sub>RD1</sub> + t<sub>PDn</sub>, t<sub>CO</sub> + t<sub>RD1</sub> + t<sub>PDn</sub>, or t<sub>PD1</sub> + t<sub>RD1</sub> + t<sub>SUP</sub>, whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
- Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.
- Set-up and hold timing parameters for the Input Buffer Latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.
- Delays based on 35 pF loading.

**Table 44 • A42MX36 Timing Characteristics (Nominal 5.0 V Operation)(Worst-Case Commercial Conditions, VCCA = 4.75 V, TJ = 70°C)**

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
<b>Asynchronous SRAM Operations</b>											
t <sub>RPD</sub>	Asynchronous Access Time		8.1		9.0		10.2		12.0		16.8 ns
t <sub>RDADV</sub>	Read Address Valid		8.8		9.8		11.1		13.0		18.2 ns
t <sub>ADSU</sub>	Address/Data Set-Up Time		1.6		1.8		2.0		2.4		3.4 ns
t <sub>ADH</sub>	Address/Data Hold Time		0.0		0.0		0.0		0.0		0.0 ns
t <sub>RENSUA</sub>	Read Enable Set-Up to Address Valid		0.6		0.7		0.8		0.9		1.3 ns
t <sub>RENHA</sub>	Read Enable Hold		3.4		3.8		4.3		5.0		7.0 ns
t <sub>WENSU</sub>	Write Enable Set-Up		2.7		3.0		3.4		4.0		5.6 ns
t <sub>WENH</sub>	Write Enable Hold		0.0		0.0		0.0		0.0		0.0 ns
t <sub>DOH</sub>	Data Out Hold Time		1.2		1.3		1.5		1.8		2.5 ns
<b>Input Module Propagation Delays</b>											
t <sub>INPY</sub>	Input Data Pad-to-Y		1.0		1.1		1.3		1.5		2.1 ns
t <sub>INGO</sub>	Input Latch Gate-to-Output		1.4		1.6		1.8		2.1		2.9 ns
t <sub>INH</sub>	Input Latch Hold		0.0		0.0		0.0		0.0		0.0 ns
t <sub>INSU</sub>	Input Latch Set-Up		0.5		0.5		0.6		0.7		1.0 ns
t <sub>ILA</sub>	Latch Active Pulse Width		4.7		5.2		5.9		6.9		9.7 ns
<b>Input Module Predicted Routing Delays<sup>2</sup></b>											
t <sub>IRD1</sub>	FO = 1 Routing Delay		2.0		2.2		2.5		2.9		4.1 ns
t <sub>IRD2</sub>	FO = 2 Routing Delay		2.3		2.6		2.9		3.4		4.8 ns
t <sub>IRD3</sub>	FO = 3 Routing Delay		2.6		2.9		3.3		3.9		5.5 ns
t <sub>IRD4</sub>	FO = 4 Routing Delay		3.0		3.3		3.8		4.4		6.2 ns
t <sub>IRD8</sub>	FO = 8 Routing Delay		4.3		4.8		5.5		6.4		9.0 ns
<b>Global Clock Network</b>											
t <sub>CKH</sub>	Input LOW to HIGH	FO = 32	2.7		3.0		3.4		4.0		5.6 ns
		FO = 635	3.0		3.3		3.8		4.4		6.2 ns
t <sub>CKL</sub>	Input HIGH to LOW	FO = 32	3.8		4.2		4.8		5.6		7.8 ns
		FO = 635	4.9		5.4		6.1		7.2		10.1 ns
t <sub>PWH</sub>	Minimum Pulse Width HIGH	FO = 32	1.8		2.0		2.2		2.6		3.6 ns
		FO = 635	2.0		2.2		2.5		2.9		4.1 ns
t <sub>PWL</sub>	Minimum Pulse Width LOW	FO = 32	1.8		2.0		2.2		2.6		3.6 ns
		FO = 635	2.0		2.2		2.5		2.9		4.1 ns
t <sub>CKSW</sub>	Maximum Skew	FO = 32	0.8		0.8		0.9		1.0		1.4 ns
		FO = 635	0.8		0.8		0.9		1.0		1.4 ns

**Table 53 • PQ208**

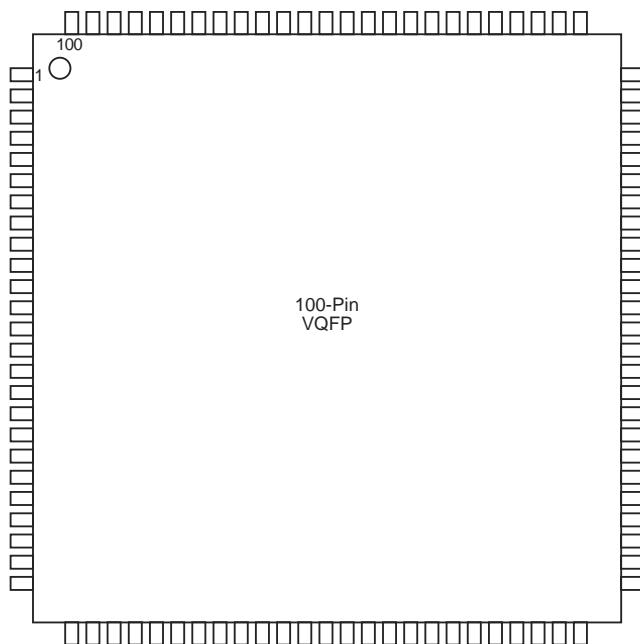
<b>PQ208</b>	<b>Pin Number</b>	<b>A42MX16 Function</b>	<b>A42MX24 Function</b>	<b>A42MX36 Function</b>
	95	NC	I/O	I/O
	96	NC	I/O	I/O
	97	NC	I/O	I/O
	98	VCCI	VCCI	VCCI
	99	I/O	I/O	I/O
	100	I/O	WD, I/O	WD, I/O
	101	I/O	WD, I/O	WD, I/O
	102	I/O	I/O	I/O
	103	SDO, I/O	SDO, TDO, I/O	SDO, TDO, I/O
	104	I/O	I/O	I/O
	105	GND	GND	GND
	106	NC	VCCA	VCCA
	107	I/O	I/O	I/O
	108	I/O	I/O	I/O
	109	I/O	I/O	I/O
	110	I/O	I/O	I/O
	111	I/O	I/O	I/O
	112	NC	I/O	I/O
	113	NC	I/O	I/O
	114	NC	I/O	I/O
	115	NC	I/O	I/O
	116	I/O	I/O	I/O
	117	I/O	I/O	I/O
	118	I/O	I/O	I/O
	119	I/O	I/O	I/O
	120	I/O	I/O	I/O
	121	I/O	I/O	I/O
	122	I/O	I/O	I/O
	123	I/O	I/O	I/O
	124	I/O	I/O	I/O
	125	I/O	I/O	I/O
	126	GND	GND	GND
	127	I/O	I/O	I/O
	128	I/O	TCK, I/O	TCK, I/O
	129	LP	LP	LP
	130	VCCA	VCCA	VCCA
	131	GND	GND	GND

**Table 53 • PQ208**

<b>PQ208</b>	<b>Pin Number</b>	<b>A42MX16 Function</b>	<b>A42MX24 Function</b>	<b>A42MX36 Function</b>
	169	I/O	WD, I/O	WD, I/O
	170	I/O	I/O	I/O
	171	NC	I/O	QCLKD, I/O
	172	I/O	I/O	I/O
	173	I/O	I/O	I/O
	174	I/O	I/O	I/O
	175	I/O	I/O	I/O
	176	I/O	WD, I/O	WD, I/O
	177	I/O	WD, I/O	WD, I/O
	178	PRA, I/O	PRA, I/O	PRA, I/O
	179	I/O	I/O	I/O
	180	CLKA, I/O	CLKA, I/O	CLKA, I/O
	181	NC	I/O	I/O
	182	NC	VCCI	VCCI
	183	VCCA	VCCA	VCCA
	184	GND	GND	GND
	185	I/O	I/O	I/O
	186	CLKB, I/O	CLKB, I/O	CLKB, I/O
	187	I/O	I/O	I/O
	188	PRB, I/O	PRB, I/O	PRB, I/O
	189	I/O	I/O	I/O
	190	I/O	WD, I/O	WD, I/O
	191	I/O	WD, I/O	WD, I/O
	192	I/O	I/O	I/O
	193	NC	I/O	I/O
	194	NC	WD, I/O	WD, I/O
	195	NC	WD, I/O	WD, I/O
	196	I/O	I/O	QCLKC, I/O
	197	NC	I/O	I/O
	198	I/O	I/O	I/O
	199	I/O	I/O	I/O
	200	I/O	I/O	I/O
	201	NC	I/O	I/O
	202	VCCI	VCCI	VCCI
	203	I/O	WD, I/O	WD, I/O
	204	I/O	WD, I/O	WD, I/O
	205	I/O	I/O	I/O

**Table 55 • VQ80**

<b>VQ80</b>		
<b>Pin Number</b>	<b>A40MX02 Function</b>	<b>A40MX04 Function</b>
13	VCC	VCC
14	I/O	I/O
15	I/O	I/O
16	I/O	I/O
17	NC	I/O
18	NC	I/O
19	NC	I/O
20	VCC	VCC
21	I/O	I/O
22	I/O	I/O
23	I/O	I/O
24	I/O	I/O
25	I/O	I/O
26	I/O	I/O
27	GND	GND
28	I/O	I/O
29	I/O	I/O
30	I/O	I/O
31	I/O	I/O
32	I/O	I/O
33	VCC	VCC
34	I/O	I/O
35	I/O	I/O
36	I/O	I/O
37	I/O	I/O
38	I/O	I/O
39	I/O	I/O
40	I/O	I/O
41	NC	I/O
42	NC	I/O
43	NC	I/O
44	I/O	I/O
45	I/O	I/O
46	I/O	I/O
47	GND	GND
48	I/O	I/O

**Figure 47 • VQ100****Table 56 • VQ100**

<b>VQ100</b>		
<b>Pin Number</b>	<b>A42MX09 Function</b>	<b>A42MX16 Function</b>
1	I/O	I/O
2	MODE	MODE
3	I/O	I/O
4	I/O	I/O
5	I/O	I/O
6	I/O	I/O
7	GND	GND
8	I/O	I/O
9	I/O	I/O
10	I/O	I/O
11	I/O	I/O
12	I/O	I/O
13	I/O	I/O
14	VCCA	NC
15	VCCI	VCCI
16	I/O	I/O
17	I/O	I/O
18	I/O	I/O
19	I/O	I/O
20	GND	GND

**Table 56 • VQ100**

VQ100		
Pin Number	A42MX09 Function	A42MX16 Function
57	I/O	I/O
58	I/O	I/O
59	I/O	I/O
60	I/O	I/O
61	I/O	I/O
62	LP	LP
63	VCCA	VCCA
64	VCCI	VCCI
65	VCCA	VCCA
66	I/O	I/O
67	I/O	I/O
68	I/O	I/O
69	I/O	I/O
70	GND	GND
71	I/O	I/O
72	I/O	I/O
73	I/O	I/O
74	I/O	I/O
75	I/O	I/O
76	I/O	I/O
77	SDI, I/O	SDI, I/O
78	I/O	I/O
79	I/O	I/O
80	I/O	I/O
81	I/O	I/O
82	GND	GND
83	I/O	I/O
84	I/O	I/O
85	PRA, I/O	PRA, I/O
86	I/O	I/O
87	CLKA, I/O	CLKA, I/O
88	VCCA	VCCA
89	I/O	I/O
90	CLKB, I/O	CLKB, I/O
91	I/O	I/O
92	PRB, I/O	PRB, I/O

**Table 59 • CQ256**

<b>CQ256</b>	
<b>Pin Number</b>	<b>A42MX36 Function</b>
22	I/O
23	I/O
24	I/O
25	I/O
26	VCCA
27	I/O
28	I/O
29	VCCA
30	VCCI
31	GND
32	VCCA
33	LP
34	TCK, I/O
35	I/O
36	GND
37	I/O
38	I/O
39	I/O
40	I/O
41	I/O
42	I/O
43	I/O
44	I/O
45	I/O
46	I/O
47	I/O
48	GND
49	I/O
50	I/O
51	I/O
52	I/O
53	I/O
54	I/O
55	I/O
56	I/O
57	I/O
58	I/O

**Table 59 • CQ256**

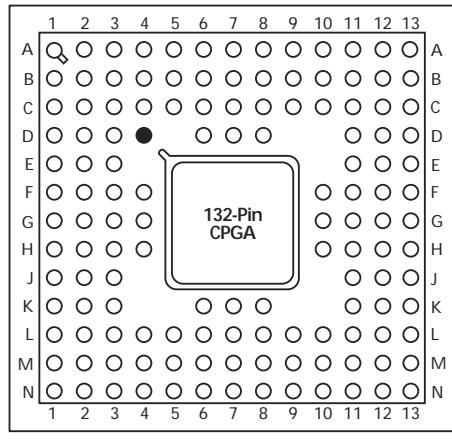
<b>CQ256</b>	
<b>Pin Number</b>	<b>A42MX36 Function</b>
170	VCCA
171	I/O
172	I/O
173	I/O
174	I/O
175	I/O
176	I/O
177	I/O
178	I/O
179	I/O
180	GND
181	I/O
182	I/O
183	I/O
184	I/O
185	I/O
186	I/O
187	I/O
188	MODE
189	VCCA
190	GND
191	NC
192	NC
193	NC
194	I/O
195	DCLK, I/O
196	I/O
197	I/O
198	I/O
199	WD, I/O
200	WD, I/O
201	VCCI
202	I/O
203	I/O
204	I/O
205	I/O
206	GND

**Table 60 • BG272**

<b>BG272</b>	
<b>Pin Number</b>	<b>A42MX36 Function</b>
A6	I/O
A7	WD, I/O
A8	WD, I/O
A9	I/O
A10	I/O
A11	CLKA
A12	I/O
A13	I/O
A14	I/O
A15	I/O
A16	WD, I/O
A17	I/O
A18	I/O
A19	GND
A20	GND
B1	GND
B2	GND
B3	DCLK, I/O
B4	I/O
B5	I/O
B6	I/O
B7	WD, I/O
B8	I/O
B9	PRB, I/O
B10	I/O
B11	I/O
B12	WD, I/O
B13	I/O
B14	I/O
B15	WD, I/O
B16	I/O
B17	WD, I/O
B18	I/O
B19	GND
B20	GND
C1	I/O
C2	MODE

**Table 60 • BG272**

<b>BG272</b>	
<b>Pin Number</b>	<b>A42MX36 Function</b>
Y13	I/O
Y14	I/O
Y15	I/O
Y16	I/O
Y17	I/O
Y18	WD, I/O
Y19	GND
Y20	GND

**Figure 52 • PG132**

● Orientation Pin

**Table 61 • PG132**

<b>PG132</b>	
<b>Pin Number</b>	<b>A42MX09 Function</b>
-	PMPOUT
B2	I/O
A1	MODE
B1	I/O
D3	I/O
C2	I/O
C1	I/O
D2	I/O
D1	I/O
E2	I/O
E1	I/O
F3	I/O

**Figure 53 • CQ172****Table 62 • CQ172**

CQ172	
Pin Number	A42MX16 Function
1	MODE
2	I/O
3	I/O
4	I/O
5	I/O
6	I/O
7	GND
8	I/O
9	I/O
10	I/O
11	I/O
12	VCC
13	I/O
14	I/O
15	I/O
16	I/O
17	GND
18	I/O
19	I/O
20	I/O

**Table 62 • CQ172**

21	I/O
22	GND
23	VCCI
24	VSV
25	I/O
26	I/O
27	VCC
28	I/O
29	I/O
30	I/O
31	I/O
32	GND
33	I/O
34	I/O
35	I/O
36	I/O
37	GND
38	I/O
39	I/O
40	I/O
41	I/O
42	I/O
43	I/O
44	BININ
45	BINOUT
46	I/O
47	I/O
48	I/O
49	I/O
50	VCCI
51	I/O
52	I/O
53	I/O
54	I/O
55	GND
56	I/O
57	I/O
58	I/O
59	I/O

**Table 62 • CQ172**

99	I/O
100	I/O
101	I/O
102	I/O
103	GND
104	I/O
105	I/O
106	VKS
107	VPP
108	GND
109	VCCI
110	VSV
111	I/O
112	I/O
113	VCC
114	I/O
115	I/O
116	I/O
117	I/O
118	GND
119	I/O
120	I/O
121	I/O
122	I/O
123	GNDI
124	I/O
125	I/O
126	I/O
127	I/O
128	I/O
129	I/O
130	I/O
131	SDI
132	I/O
133	I/O
134	I/O
135	I/O
136	VCCI
137	I/O

**Table 62 • CQ172**

138	I/O
139	I/O
140	I/O
141	GND
142	I/O
143	I/O
144	I/O
145	I/O
146	I/O
147	I/O
148	PROBA
149	I/O
150	CLKA
151	VCC
152	GND
153	I/O
154	CLKB
155	I/O
156	PROBB
157	I/O
158	I/O
159	I/O
160	I/O
161	GND
162	I/O
163	I/O
164	I/O
165	I/O
166	VCCI
167	I/O
168	I/O
169	I/O
170	I/O
171	DCLK